



Full

TEST REPORT

No. I18D00229-SRD01

For

Client : Hisense International Co., Ltd.

Production : Mobile Phone

Model Name : KS964

Brand Name : Hisense

FCC ID : 2ADOBKS964

Hardware Version: V1.00

Software Version: Hisense_KS964_MX01_L101.06

Issued date: 2019-01-10

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of ECIT Shanghai.

Test Laboratory:

ECIT Shanghai, East China Institute of Telecommunications

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RF Test Report

Report No.: I18D00229-SRD01

Revision Version

Report Number	Revision	Date	Memo
I18D00229-SRD01	00	2019-01-04	Initial creation of test report
I18D00229-SRD01	01	2019-01-10	Second creation of test report

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1. Test Laboratory

1.1. Testing Location

Company Name:	ECIT Shanghai, East China Institute of Telecommunications
Address:	7-8F, G Area, No. 668, Beijing East Road, Huangpu District, Shanghai, P. R. China
Postal Code:	200001
Telephone:	(+86)-021-63843300
Fax:	(+86)-021-63843301
FCC registration No	958356

1.2. Testing Environment

Normal Temperature:	15-35°C
Extreme Temperature:	-10/+50°C
Relative Humidity:	25-75%

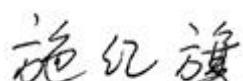
1.3. Project data

Project Leader:	Zhang Min
Testing Start Date:	2018-11-29
Testing End Date:	2018-12-06

1.4. Signature



Yang Dejun
(Prepared this test report)



Shi Hongqi
(Reviewed this test report)



Zheng Zhongbin
(Approved this test report)



2. Client Information

2.1. Applicant Information

Company Name: Hisense International Co., Ltd.
Address: Floor 22, Hisense Tower, 17 Donghai Xi Road, Qingdao, 266071, China
Telephone: +86-532-80877742
Postcode: /

2.2. Manufacturer Information

Company Name: Hisense Communications Co., Ltd.
Address: 218 Qianwangang Road, Qingdao Economic & Technological Development Zone, Qingdao, China
Telephone: +86-532-55753749
Postcode: /

3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

EUT Description	Mobile Phone
Model name	KS964
BT Frequency	2402MHz-2480MHz
BT Channel	Channel0-Channel78
BT type of modulation	GFSK/π/4 DQPSK/8DPSK
GSM Frequency Band	GSM850/GSM900/GSM1800/GSM1900
UMTS Frequency Band	Band I /Band II /Band V
CDMA Frequency Band	/
LTE Frequency Band	/
Additional Communication Function	BT4.2,BLE; WiFi 802.11b,g,n.
Extreme Temperature	-10/+50°C
Nominal Voltage	3.8V
Extreme High Voltage	4.35V
Extreme Low Voltage	3.6V

Note: Photographs of EUT are shown in ANNEX A of this test report.

3.2. Internal Identification of EUT used during the test

EUT ID*	Model Name	SN or IMEI	HW Version	SW Version	Date of receipt
N19(Main supply)	KS964	8699810400 00565	V1.00	Hisense_KS964_M X01_L101.06	2018-12-29
N15(Main supply)	KS964	8699810400 00714	V1.00	Hisense_KS964_M X01_L101.06	2018-12-29
N18(Secondary supply)	KS964	8699810400 00128	V1.00	Hisense_KS964_M X01_L101.06	2018-12-29

*EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE used during the test

AE ID*	Description	SN
AE1	RF cable	---
AE2	---	---

*AE ID: is used to identify the test sample in the lab internally.

3.4. The difference between two models

Main supply is same as Secondary supply, the two samples are only different on the supplier of TP/LCD/CAM/Memory.



4. Reference Documents

4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part15	FCC CFR 47, Part 15,Subpart C: 15.205 Restricted bands of operation; 15.209 Radiated emission limits, general requirements; 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz.	2018/10/1
ANSI C63.10	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices	2013

5. Summary of Test Results

A brief summary of the tests carried out is shown as following.

Measurement Items	Sub-clause of Part15C	Sub-clause of IC	Verdict
Maximum Peak Output Power	15.247(b)	/	P
20dB Occupied Bandwidth	15.247(a)	/	P
Band Edges Compliance	15.247(b)	/	P
Time Of Occupancy (Dwell Time)	15.247(a)	/	P
Carrier Frequency Separation	15.247(a)	/	P
Number Of Hopping Channels	15.247(a)	/	P
Transmitter Spurious Emission-Conducted	15.247	/	P
Transmitter Spurious Emission-Radiated	15.247,15.209,	/	P
AC Powerline Conducted Emission	15.107,15.207	/	P

Please refer to part 5 for detail.

The measurements are according to ANSI C63.10.

Terms used in Verdict column

P	Pass, the EUT complies with the essential requirements in the standard.
NP	Not Perform, the test was not performed by ECIT.
NA	Not Applicable, the test was not applicable.
F	Fail, the EUT does not comply with the essential requirements in the standard.

Test Conditions

T _{nom}	Normal Temperature
T _{min}	Low Temperature
T _{max}	High Temperature
V _{nom}	Normal Voltage
V _{min}	Low Voltage



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Vmax	High Voltage
Hnom	Norm Humidity
Anom	Norm Air Pressure

For this report, all the test case listed above are tested under Normal Temperature and Normal Voltage, and also under norm humidity, the specific conditions as following:

Temperature	Tnom	25°C
Voltage	Vnom	3.8V
Humidity	Hnom	48%
Air Pressure	Anom	1010hPa

Note:

- a. All the test data for each data were verified, but only the worst case was reported.
- b.The GFSK, $\pi/4$ DQPSK and 8DPSK were set in DH1 for GFSK, 2-DH1 for $\pi/4$ DQPSK, 3-DH1 for 8DPSK.
- c.The DC and low frequency voltages' measurement uncertainty is $\pm 2\%$.

5.1. Notes

All reported tests were carried out on a sample equipment to demonstrate limited compliance with section 3.

The test results of this test report relate exclusively to the item(s) tested as specified in section 5.

5.2. Statements

The KS964, support GSM/GPRS/WCDMA /BT/BLE/ WLAN, manufactured by Hisense Communications Co., Ltd., which is a new product for testing.

Note: The product has two prototypes, the two samples are only different on the supplier of TP/LCD/CAM/Memory. In this report, we test all cases about main supply, and we only test the AC Powerline and the worse case of RSE about secondary supply.

ECIT has verified that the compliance of the tested device specified in section 5 of this test report is successfully evaluated according to the procedure and test methods as defined in type certification requirement listed in section 5 of this test report.

6. Test result

6.1. Peak Output Power-Conducted

6.1.1 Measurement Limit

Standard	Limit (dBm)
FCC Part 15.247(b)(1)	< 30

6.1.2 Test Condition:

Hopping Mode	RBW	VBW	Span	Sweptime
Hopping OFF	3MHz	10MHz	9MHz	Auto

6.1.3 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.5.

1. The output power of EUT was connected to the spectrum analyzer and CBT32 by cable and divide. The path loss was compensated to the results for each measurement.
2. Enable EUT transmitter maximum power continuously.
3. Measure the conducted output power and record the results it.

6.1.4 Measurement Uncertainty:

Measurement Uncertainty	±0.88dB
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6.1.5 Measurement Results:

For GFSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	5.77	6.29	6.15	P
	Fig.1	Fig.2	Fig.3	

For π/4 DQPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	5.78	6.18	5.88	P
	Fig.4	Fig.5	Fig.6	

For 8DPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	5.73	6.20	5.93	P
	Fig.7	Fig.8	Fig.9	

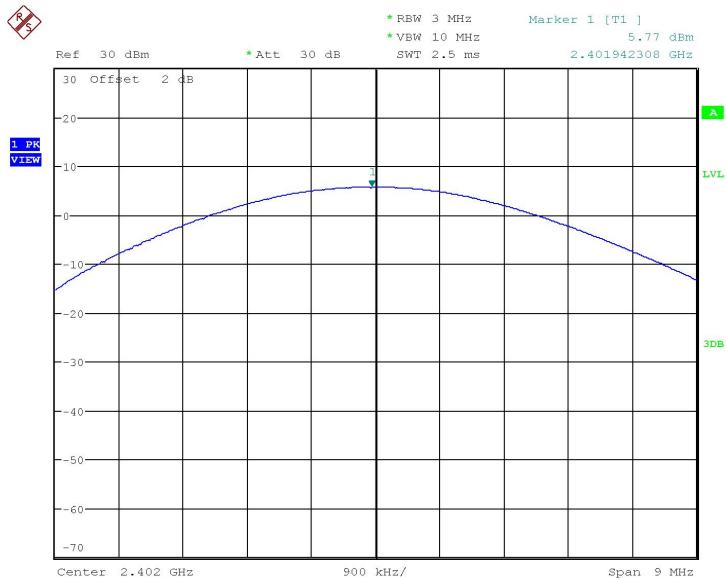
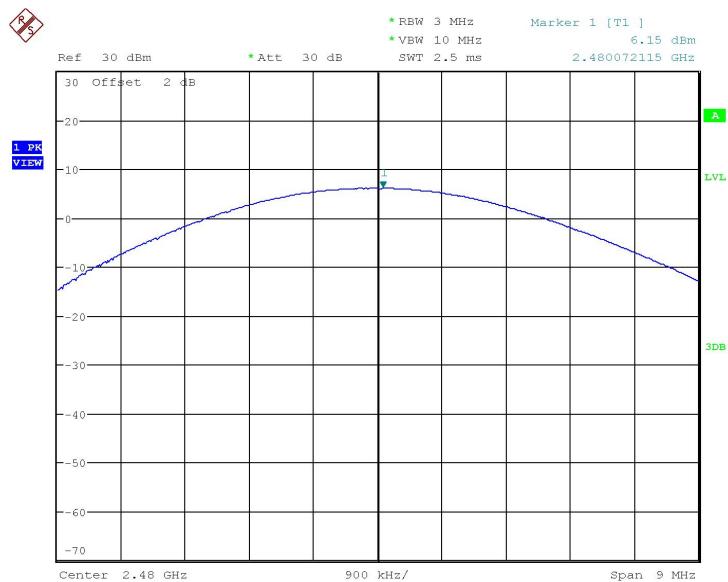
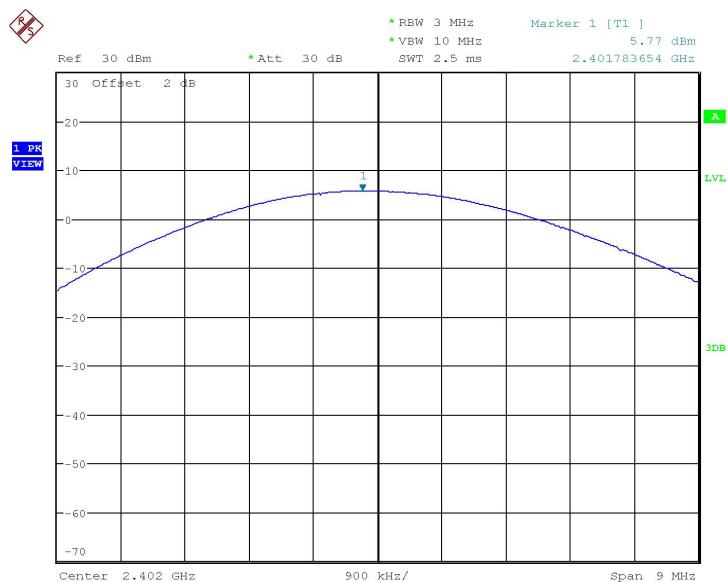
Conclusion: PASS
Test graphs an below

Fig.1 Peak Conducted Output Power CH0, DH1


Fig.2 Peak Conducted Output Power CH39, DH1



Date: 29.NOV.2018 08:23:35

Fig.3 Peak Conducted Output Power CH78, DH1



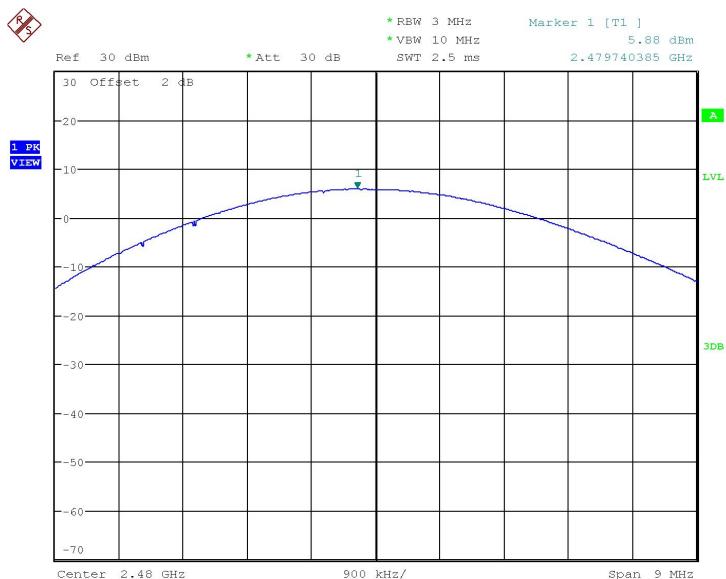
Date: 29.NOV.2018 08:24:56

Fig.4 Peak Conducted Output Power CH0, 2DH1



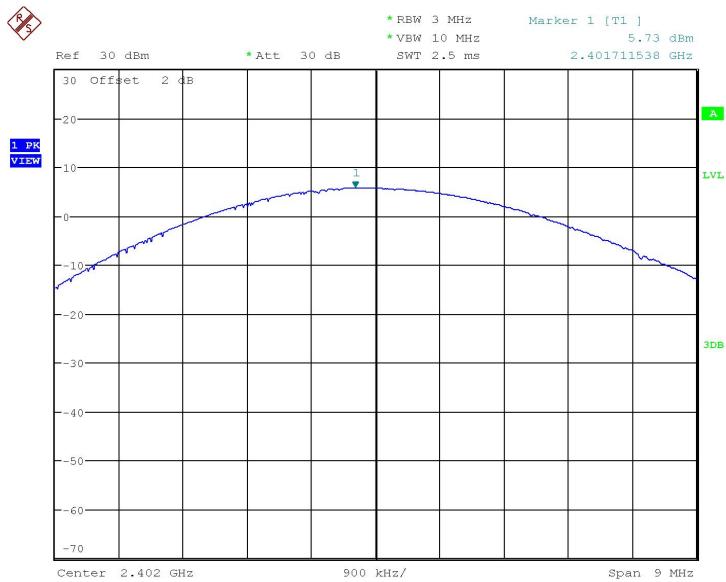
Date: 29.NOV.2018 08:25:44

Fig.5 Peak Conducted Output Power CH39, 2DH1



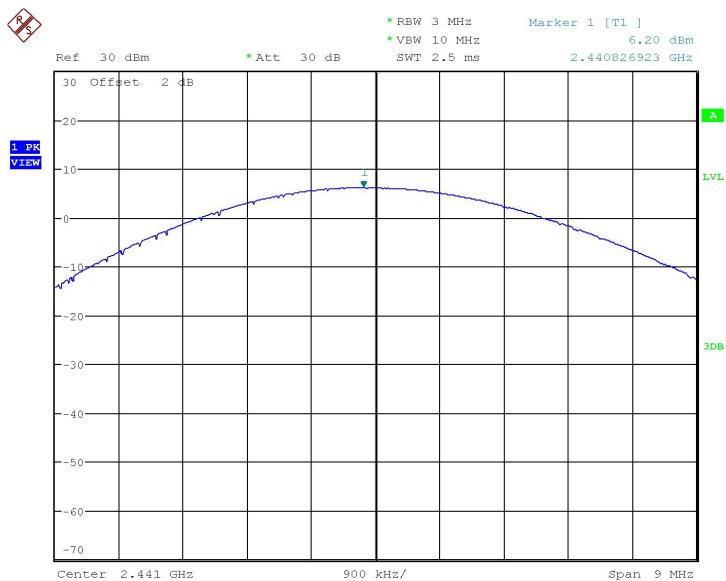
Date: 29.NOV.2018 08:27:02

Fig.6 Peak Conducted Output Power CH78, 2DH1



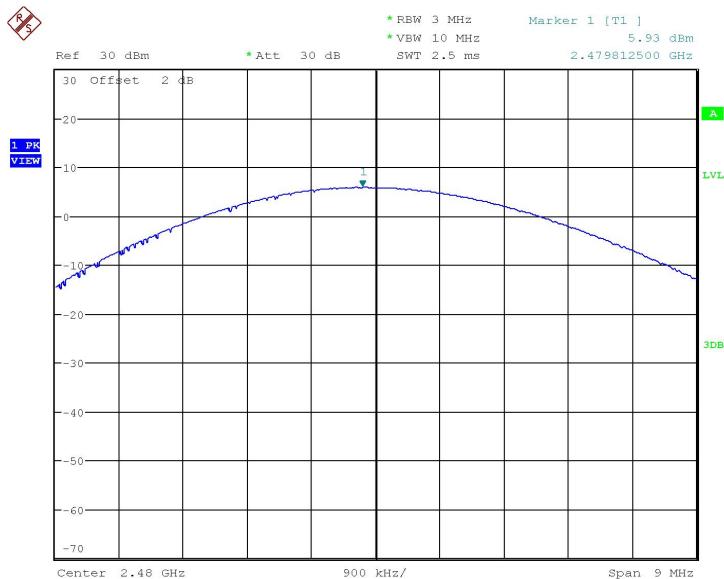
Date: 29.NOV.2018 08:28:40

Fig.7 Peak Conducted Output Power CH0, 3DH1



Date: 29.NOV.2018 08:31:05

Fig.8 Peak Conducted Output Power CH39, 3DH1



Date: 29.NOV.2018 08:31:53

Fig.9 Peak Conducted Output Power CH78, 3DH1

6.2. Frequency Band Edges-Conducted

6.2.1 Measurement Limit:

Standard	Limited(dBc)
FCC 47 CFR Part 15.247(d)	>20

6.2.2 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.6.

1. Connect the EUT to spectrum analyzer.
2. Set RBW=100KHz, VBW=300KHz, span more than 1.5 times channel bandwidth (2MHz).
3. Detector =peak, sweep time=auto couple, trace mode=max hold.
4. Allow sweep to continue until the trace stabilizes.

6.2.3 Measurement Uncertainty:

Measurement Uncertainty	±4.56dB
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6.2.4 Measurement results

For GFSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion



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0	Hopping OFF	Fig.10	P
	Hopping ON	Fig.11	P
78	Hopping OFF	Fig.12	P
	Hopping ON	Fig.13	P

For π/4 DQPSK

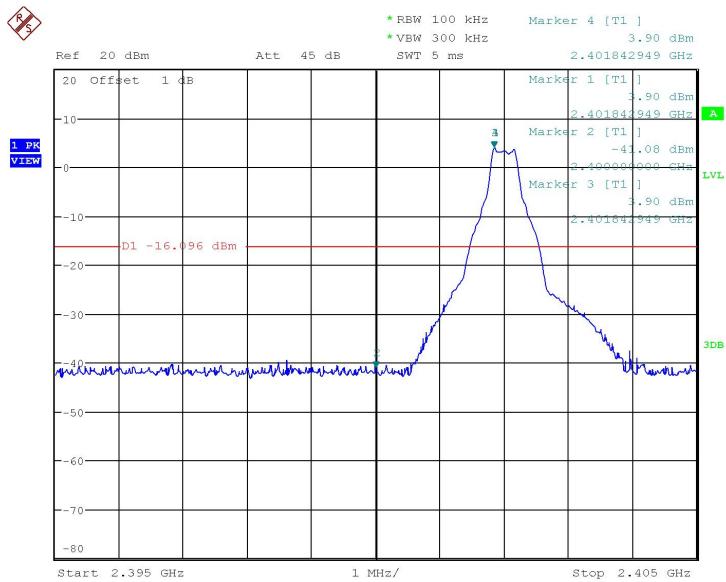
Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.14	P
	Hopping ON	Fig.15	P
78	Hopping OFF	Fig.16	P
	Hopping ON	Fig.17	P

For 8DPSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.18	P
	Hopping ON	Fig.19	P
78	Hopping OFF	Fig.20	P
	Hopping ON	Fig.21	P

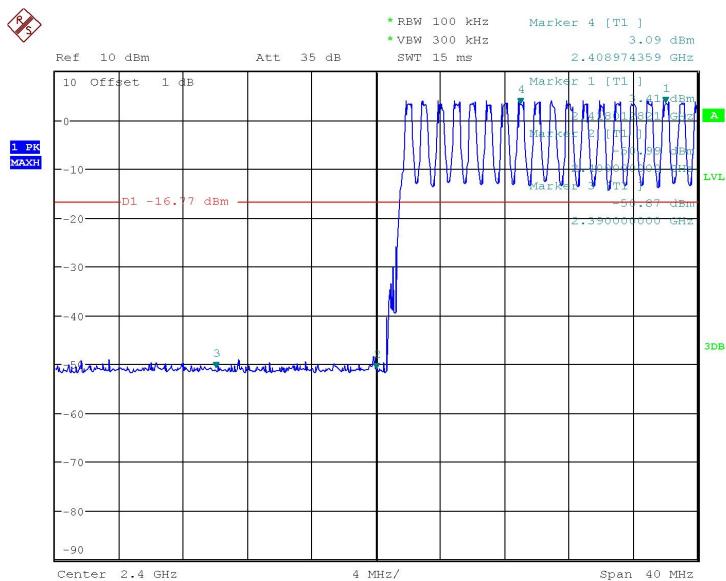
Conclusion: PASS

Test graphs an below



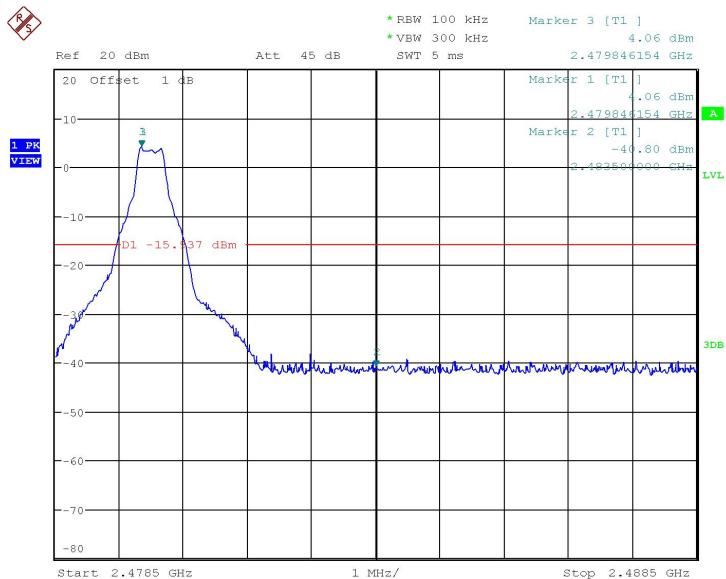
Date: 6.DEC.2018 10:19:59

Fig.10 Frequency Band Edge: GFSK, Ch0, Hopping OFF



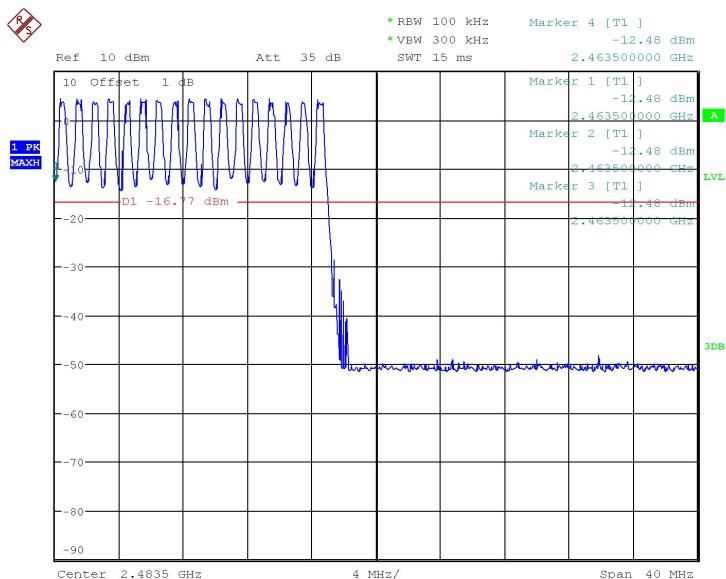
Date: 7.DEC.2018 04:01:54

Fig.11 Frequency Band Edge: GFSK, Ch0, Hopping ON



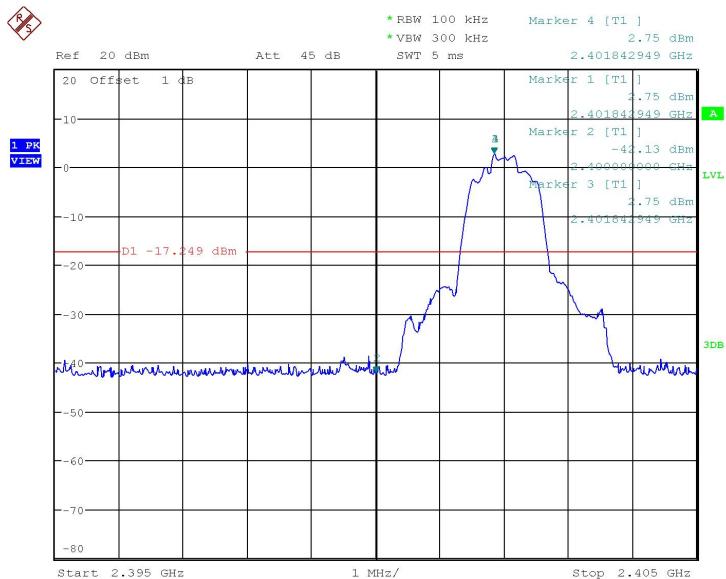
Date: 6.DEC.2018 10:25:54

Fig.12 Frequency Band Edge: GFSK, Ch78, Hopping OFF



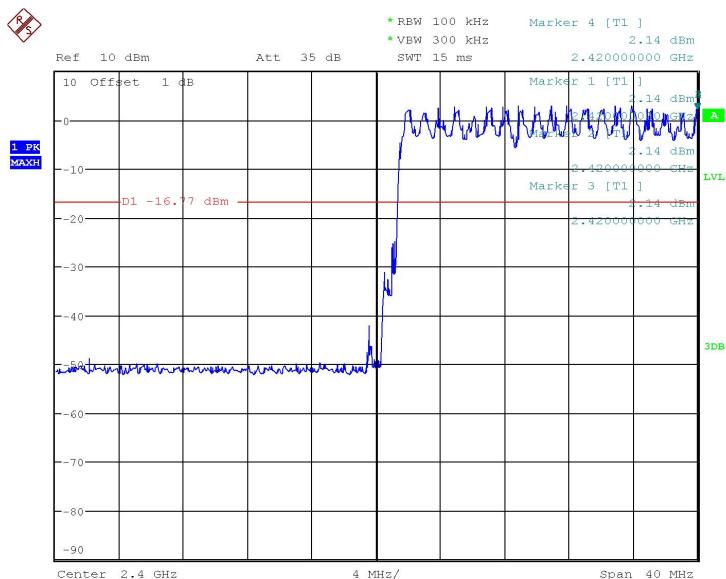
Date: 7.DEC.2018 04:04:30

Fig.13 Frequency Band Edge: GFSK, Ch78, Hopping ON



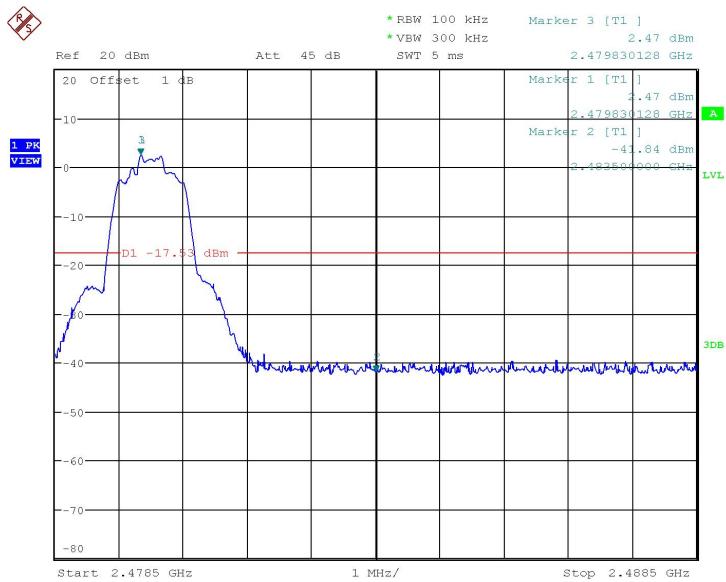
Date: 6.DEC.2018 10:28:12

Fig.14 Frequency Band Edge: $\pi/4$ DQPSK, Ch0, Hopping OFF



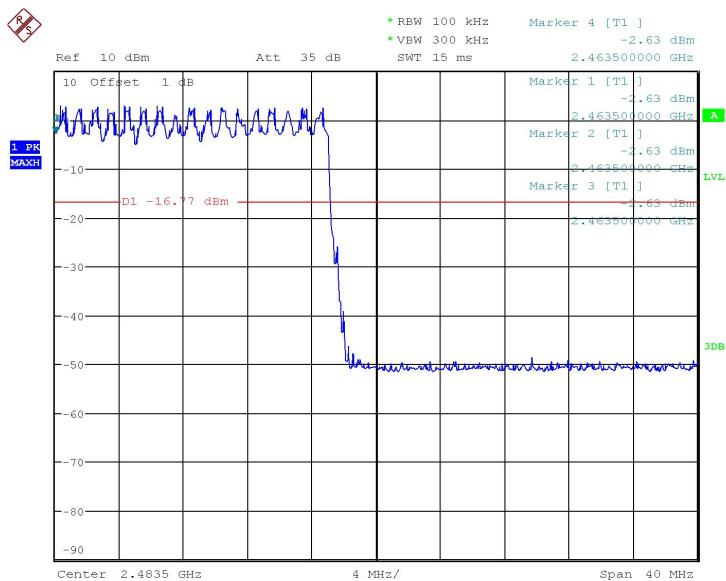
Date: 7.DEC.2018 04:08:29

Fig.15 Frequency Band Edge: $\pi/4$ DQPSK, Ch0, Hopping ON



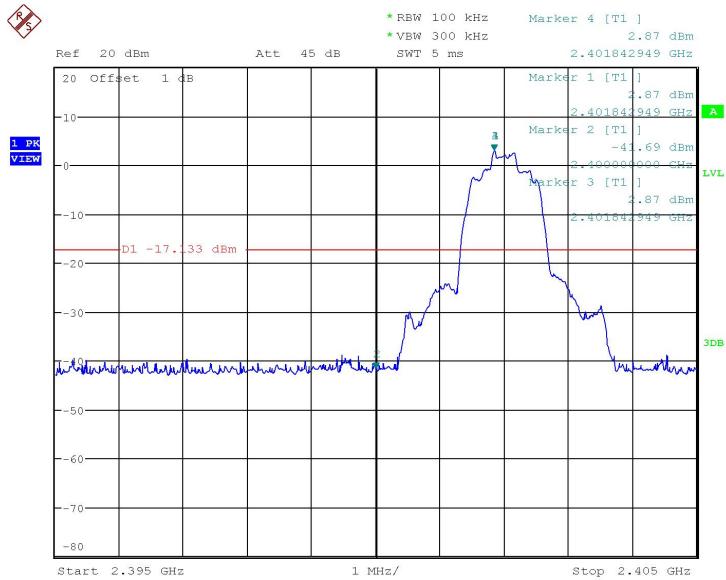
Date: 6.DEC.2018 10:33:24

Fig.16 Frequency Band Edge: $\pi/4$ DQPSK, Ch78, Hopping OFF



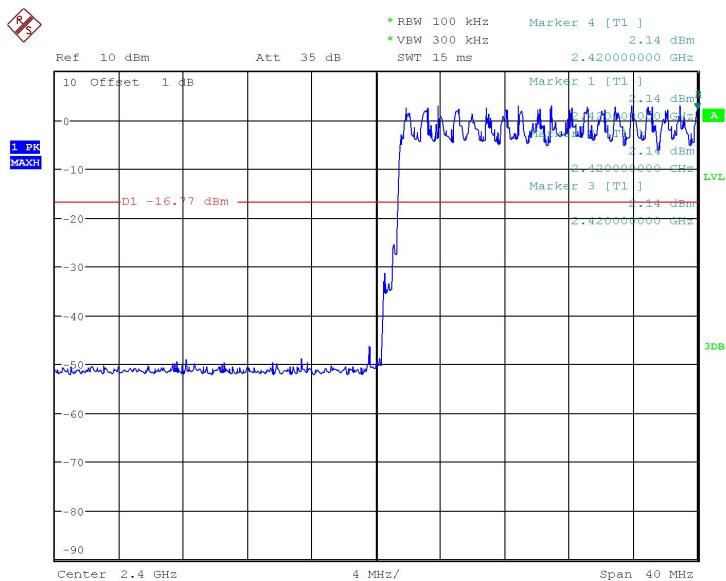
Date: 7.DEC.2018 04:11:19

Fig.17 Frequency Band Edge: $\pi/4$ DQPSK, Ch78, Hopping ON



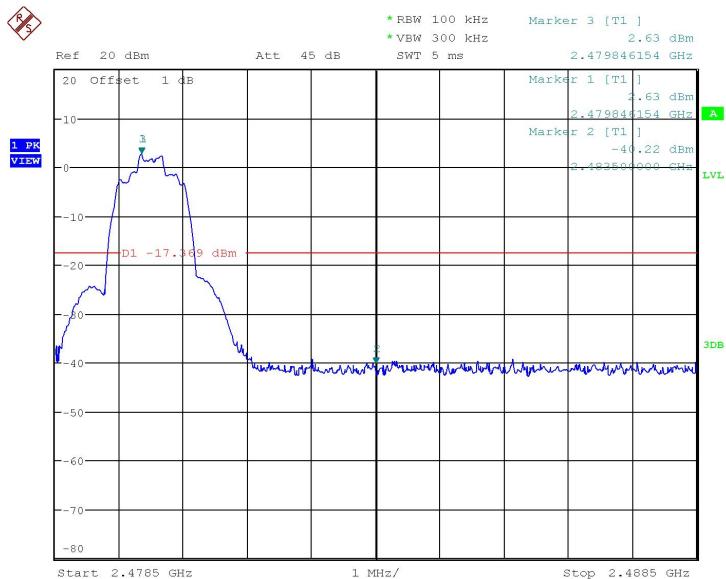
Date: 6.DEC.2018 10:35:47

Fig.18 Frequency Band Edge: 8DPSK, Ch0, Hopping OFF



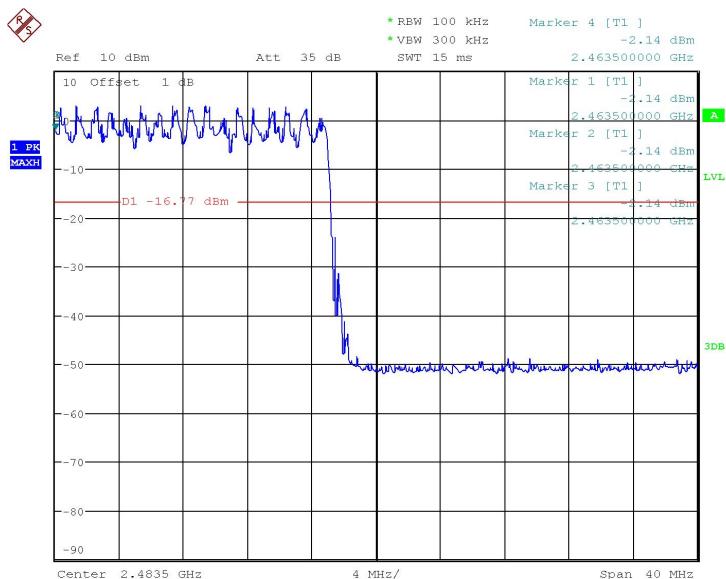
Date: 7.DEC.2018 04:14:08

Fig.19 Frequency Band Edge: 8DPSK, Ch0, Hopping ON



Date: 6.DEC.2018 10:40:19

Fig.20 Frequency Band Edge: 8DPSK, Ch78, Hopping OFF



Date: 7.DEC.2018 04:16:03

Fig.21 Frequency Band Edge: 8DPSK, Ch78, Hopping ON

6.3. Conducted Emission

6.3.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part15.247 (d)	20dB below peak output power in 100KHz bandwidth

6.3.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.8.8.

1. Connect the EUT to spectrum analyzer.
2. Set RBW=100KHz, VBW=300KHz.
3. Detector =peak, sweep time=auto couple, trace mode=max hold.

6.3.3 Measurement Uncertainty:

Measurement Uncertainty	±4.56dB
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6.3.4 Measurement Results:**For GFSK**

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.22	P
	30MHz~26GHz	Fig.23	P
Ch39 2441MHz	Center Freq.	Fig.24	P
	30MHz~26GHz	Fig.25	P
Ch78 2480MHz	Center Freq.	Fig.26	P
	30MHz~26GHz	Fig.27	P

For π/4 DQPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.28	P
	30MHz~26GHz	Fig.29	P
Ch39 2441MHz	Center Freq.	Fig.30	P
	30MHz~26GHz	Fig.31	P
Ch78 2480MHz	Center Freq.	Fig.32	P
	30MHz~26GHz	Fig.33	P

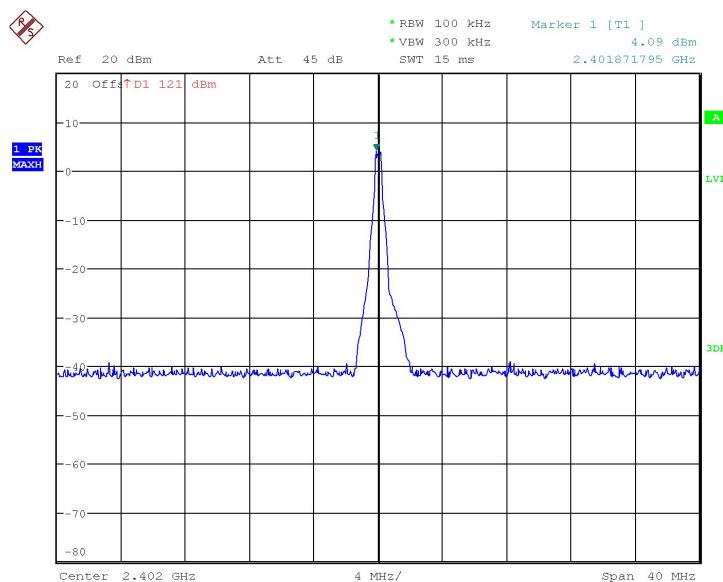
For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.34	P
	30MHz~26GHz	Fig.35	P

Ch39 2441MHz	Center Freq.	Fig.36	P
	30MHz~26GHz	Fig.37	P
Ch78 2480MHz	Center Freq.	Fig.38	P
	30MHz~26GHz	Fig.39	P

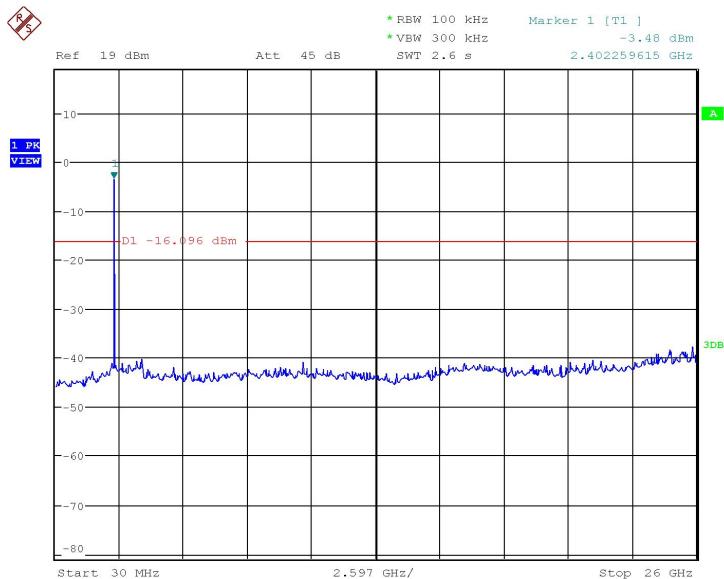
Conclusion: PASS

Test graphs as below



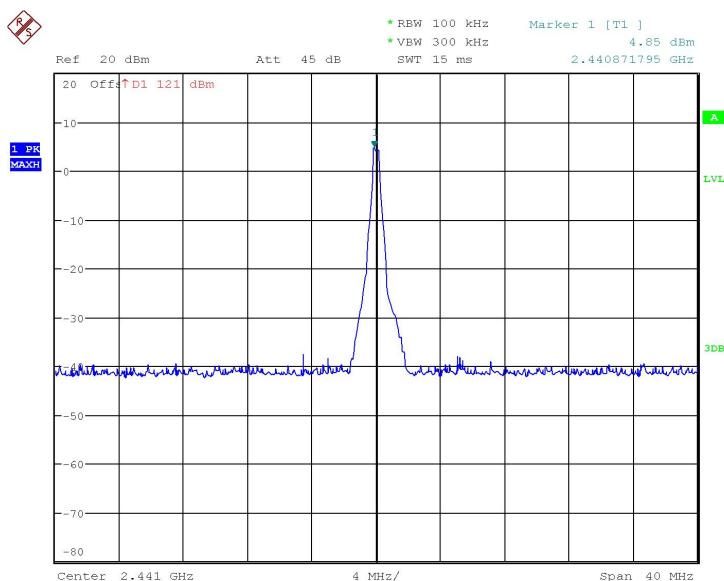
Date: 7.DEC.2018 03:31:57

Fig.22 Conducted spurious emission: GFSK, Ch0, 2402MHz



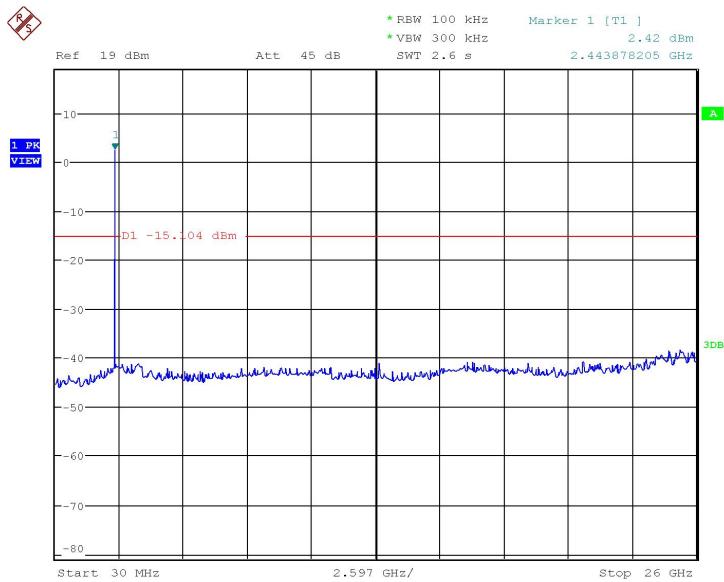
Date: 6.DEC.2018 10:20:43

Fig.23 Conducted spurious emission: GFSK, Ch0, 30MHz~26GHz



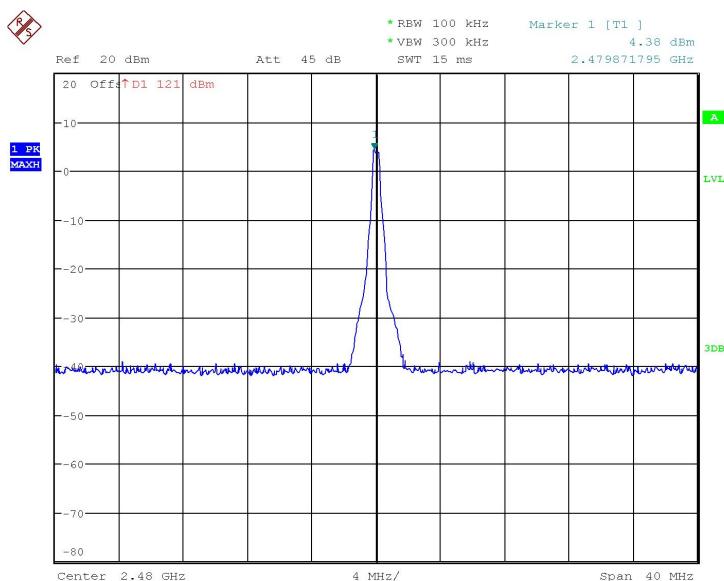
Date: 7.DEC.2018 03:34:08

Fig.24 Conducted spurious emission: GFSK, Ch39, 2441MHz



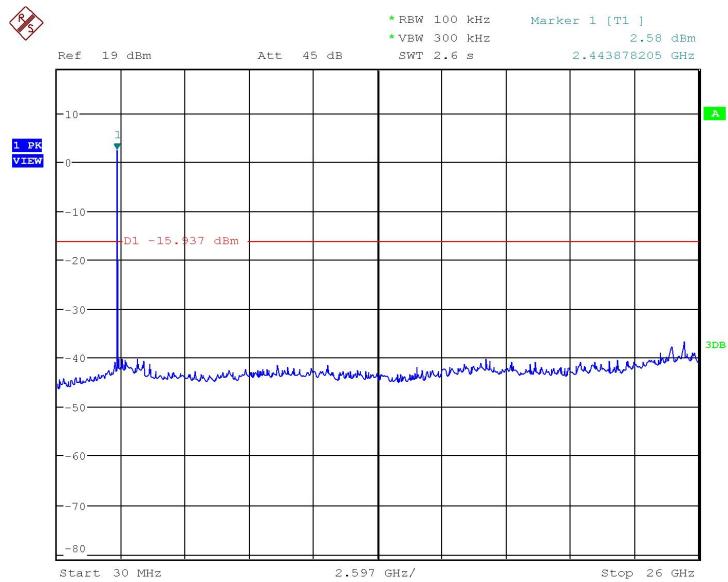
Date: 6.DEC.2018 10:23:13

Fig.25 Conducted spurious emission: GFSK, Ch39, 30MHz~26GHz



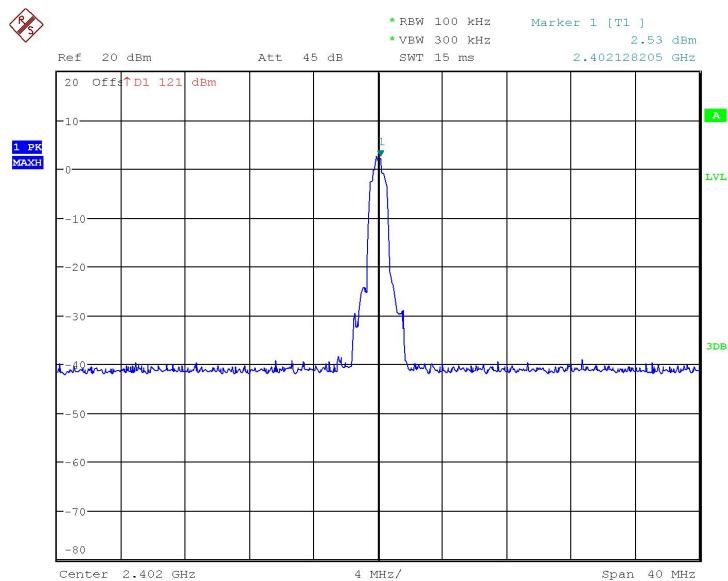
Date: 7.DEC.2018 03:37:38

Fig.26 Conducted spurious emission: GFSK, Ch78, 2480MHz



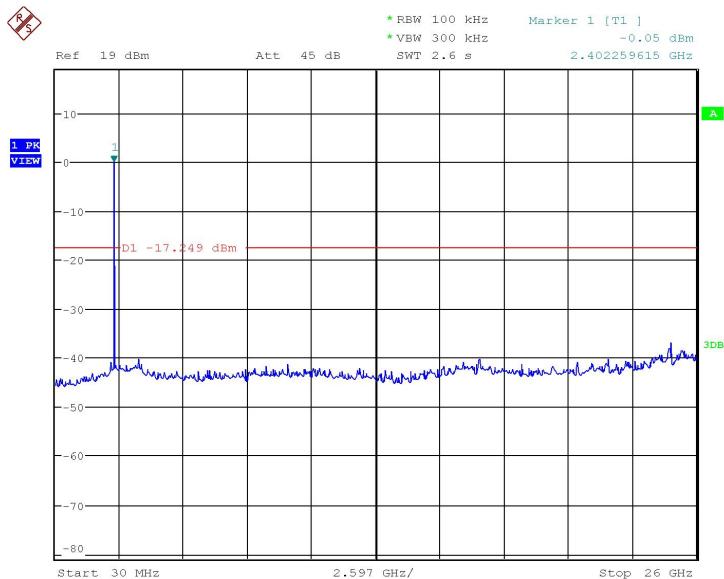
Date: 6.DEC.2018 10:26:38

Fig.27 Conducted spurious emission: GFSK, Ch78, 30MHz~26GHz



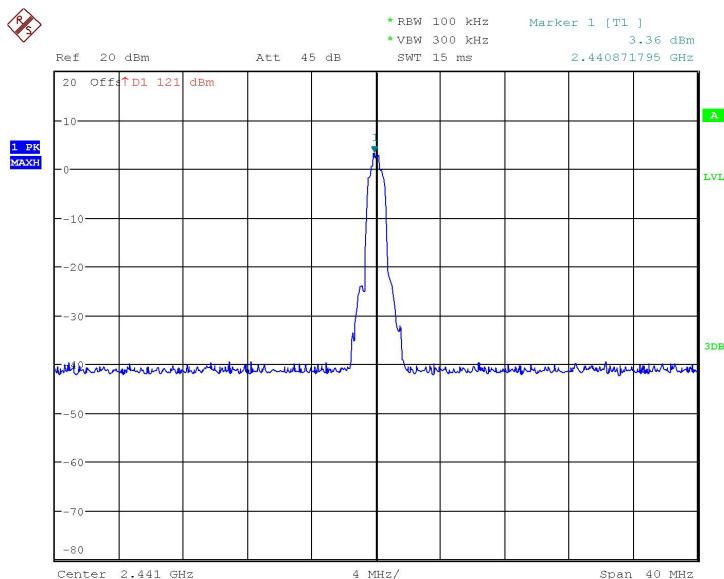
Date: 7.DEC.2018 03:41:37

Fig.28 Conducted spurious emission: $\pi/4$ DQPSK, Ch0, 2402MHz



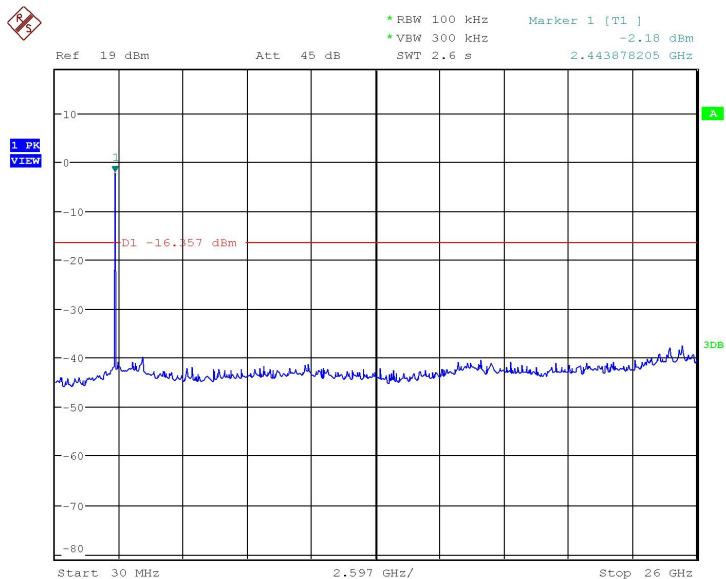
Date: 6.DEC.2018 10:28:56

Fig.29 Conducted spurious emission: π/4 DQPSK, Ch0, 30MHz~26GHz



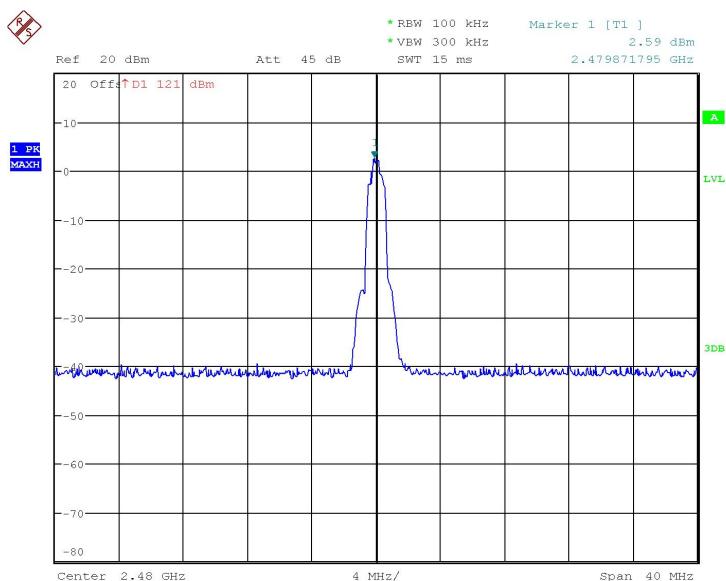
Date: 7.DEC.2018 03:45:22

Fig.30 Conducted spurious emission: π/4 DQPSK, Ch39, 2441MHz



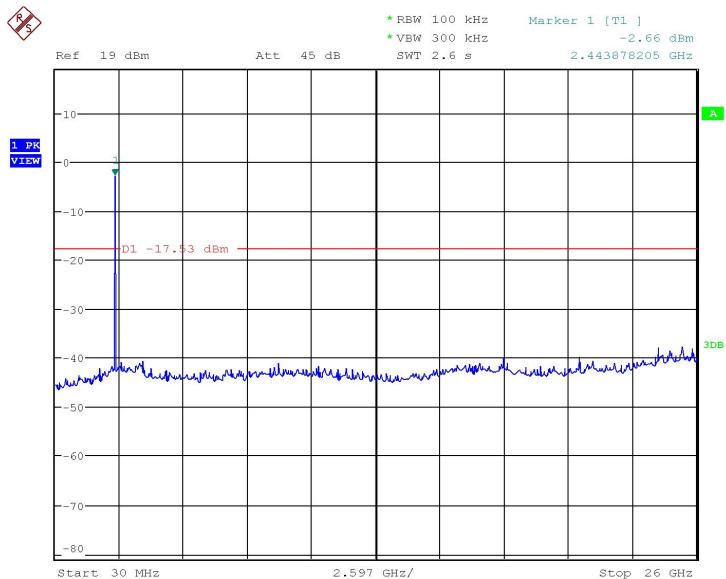
Date: 6.DEC.2018 10:32:03

Fig.31 Conducted spurious emission: π/4 DQPSK, Ch39, 30MHz~26GHz



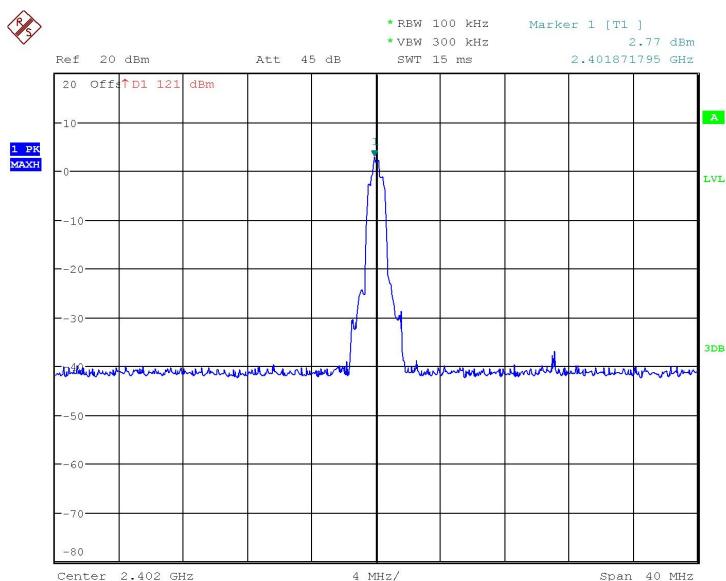
Date: 7.DEC.2018 03:46:58

Fig.32 Conducted spurious emission: π/4 DQPSK, Ch78, 2480MHz



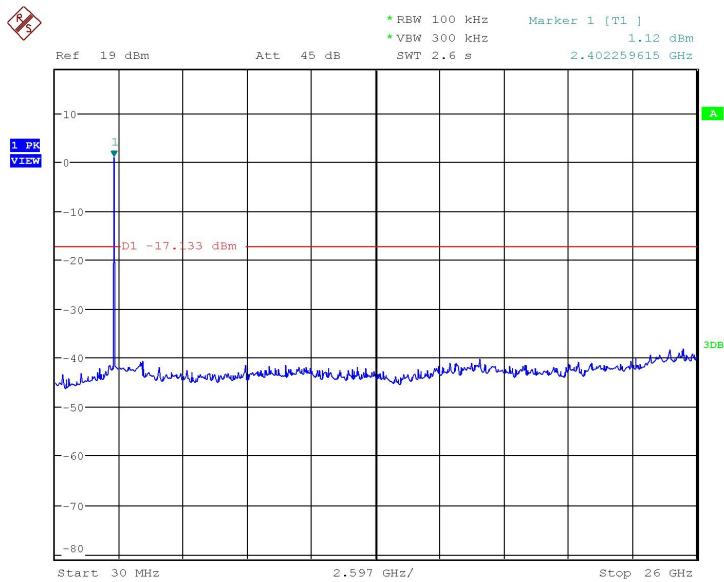
Date: 6.DEC.2018 10:34:08

Fig.33 Conducted spurious emission: π/4 DQPSK, Ch78, 30MHz~26GHz



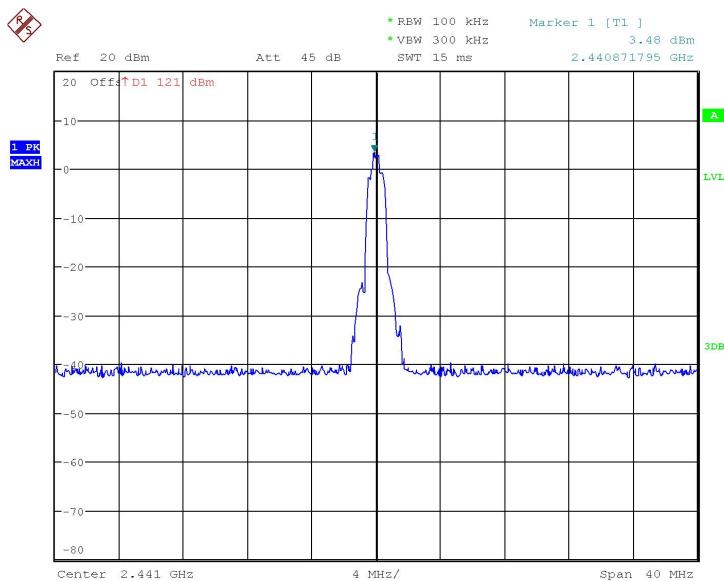
Date: 7.DEC.2018 03:50:10

Fig.34 Conducted spurious emission: 8DPSK, Ch0, 2402MHz



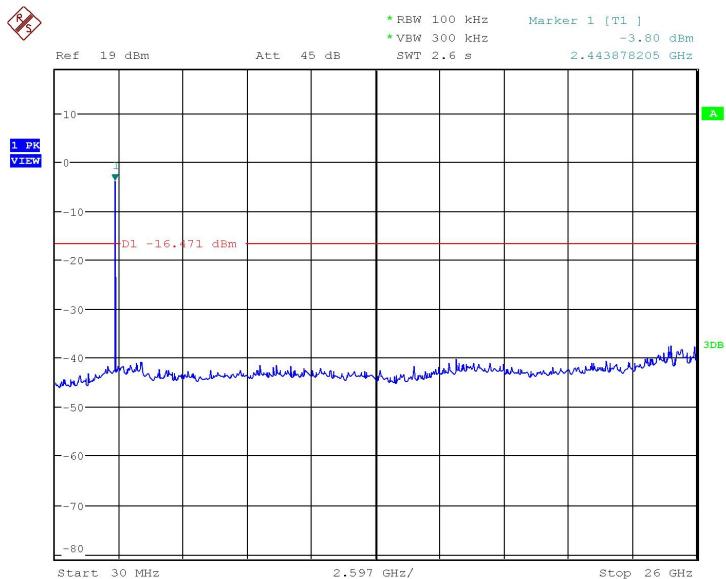
Date: 6.DEC.2018 10:36:31

Fig.35 Conducted spurious emission: 8DPSK, Ch0, 30MHz~26GHz



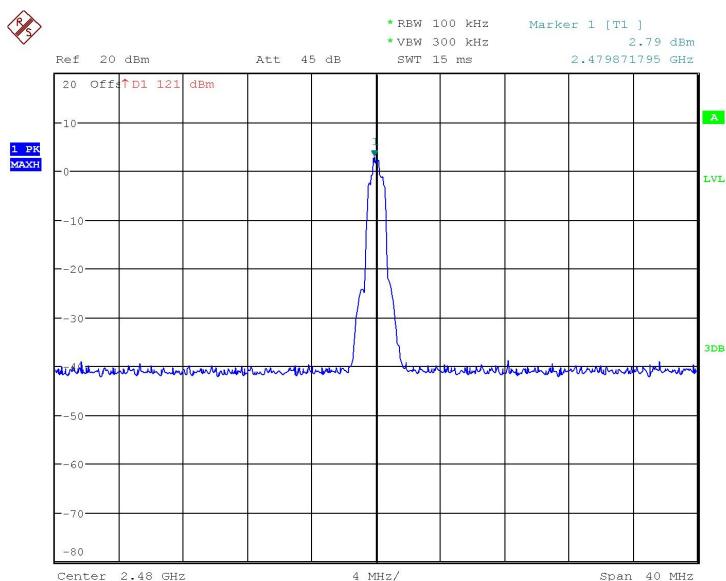
Date: 7.DEC.2018 03:52:18

Fig.36 Conducted spurious emission: 8DPSK, Ch39, 2441MHz



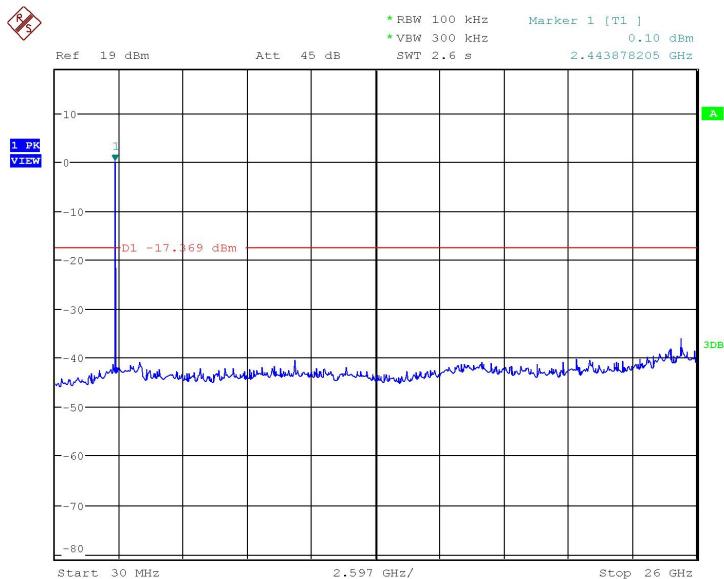
Date: 6.DEC.2018 10:38:53

Fig.37 Conducted spurious emission: 8DPSK, Ch39, 30MHz~26GHz



Date: 7.DEC.2018 03:54:36

Fig.38 Conducted spurious emission: 8DPSK, Ch78, 2480MHz



Date: 6.DEC.2018 10:41:03

Fig.39 Conducted spurious emission: 8DPSK, Ch78, 30MHz~26GHz

6.4. Radiated Emission

6.4.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247, 15.205, 15.209	20dB below peak output power

In addition, radiated emissions which fall in the restricted bands, as defined in 15.205(a), must also comply with the radiated emission limits specified in 15.205(a) (see 15.205(c)).

Limit in restricted band:

Frequency of emission (MHz)	Field strength (uV/m)	Field strength (dBuV/m)
30~88	100	40
88~216	150	43.5
216~960	200	46
Above 960	500	54

Measurement Uncertainty

Measurement Items	Range	Confidence Level	Calculated Uncertainty
Transmitter Spurious Emission-Radiated	9KHz-30MHz	95%	±5.66db



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Transmitter Spurious Emission-Radiated	30MHz-1000MHz	95%	$\pm 4.98\text{db}$
Transmitter Spurious Emission-Radiated	1000MHz -18000MHz	95%	$\pm 5.06\text{db}$
Transmitter Spurious Emission-Radiated	18000MHz -40000MHz	95%	$\pm 5.20\text{db}$

6.4.2 Test Method

Portable, small, lightweight, or modular devices that may be handheld, worn on the body, or placed on a table during operation shall be positioned on a non-conducting platform, the top of which is 80 cm above the reference ground plane. The preferred area occupied by the EUT arrangement is 1 m by 1.5 m, For emissions testing at or below 1 GHz, the table height shall be 80 cm above the reference ground plane. For emission measurements above 1 GHz, the table height shall be 1.5 m but it may be larger or smaller to accommodate various sized EUTs. For testing purposes, ceiling- and wall-mounted devices also shall be positioned on a tabletop (see also ANSI C63.10-2013 section 6.3.4 and 6.3.5). In making any tests involving handheld, body-worn, or ceiling-mounted equipment, it is essential to recognize that the measured levels may be dependent on the orientation (attitude) of the three orthogonal axes of the EUT. Thus, exploratory tests as specified in 8.3.1 shall be carried out for various axes orientations to determine the attitude having maximum or near-maximum emission level.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

Frequency of emission (MHz)	RBW/VBW	Sweep Time (s)
30~1000	100KHz/300KHz	5
1000~4000	1MHz/3MHz	15
4000~18000	1MHz/3MHz	40
18000~26500	1MHz/3MHz	20

6.4.3 Measurement Results:

A “reference path loss” is established and A_{Rpi} is the attenuation of “reference path loss”, and including the gain of receive antenna, the gain of the preamplifier, the cable loss.

The measurement results are obtained as described below:

$$A_{Rpi} = \text{Cable loss} + \text{Antenna Gain-Preamplifier gain}$$

$$\text{Result} = P_{Mea} + A_{Rpi}$$

Main supply



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For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch78 2480MHz	30MH~1GHz	Fig.40	P
	1GHz~3GHz	Fig.41	P
	3GHz~18GHz	Fig.42	P
Power(low)	2.31GHz~2.5GHz	Fig.43	P
Power(high)	2.31GHz~2.5GHz	Fig.44	P

For π/4 DQPSK

Channel	Frequency Range	Test Results	Conclusion
Ch78 2480MHz	30MH~1GHz	Fig.45	P
	1GHz~3GHz	Fig.46	P
	3GHz~18GHz	Fig.47	P
Power(low)	2.31GHz~2.5GHz	Fig.48	P
Power(high)	2.31GHz~2.5GHz	Fig.49	P

For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch78 2480MHz	30MH~1GHz	Fig.50	P
	1GHz~3GHz	Fig.51	P
	3GHz~18GHz	Fig.52	P
Power(low)	2.31GHz~2.5GHz	Fig.53	P
Power(high)	2.31GHz~2.5GHz	Fig.54	P

GFSK Ch78 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
34.3	19.76	-22	41.76	V
34.7	16.21	-22	38.21	V
34.8	16.63	-21.9	38.53	V
41.1	27.89	-20.6	48.49	V



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41.5	28.13	-20.5	48.63	V
48.2	12.4	-20	32.4	V

GFSK Ch78 1GHz-3GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2537.1	54.07	7	47.07	H
2611.6	54.48	7.4	47.08	V
2693.7	54.37	7.9	46.47	V
2728.6	54.56	7.8	46.76	V
2865.7	55.74	8.5	47.24	V
2955.7	55.32	8.7	46.62	V

GFSK Ch78 1GHz-3GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2537.1	41.85	7	34.85	H
2611.6	41.87	7.4	34.47	V
2693.7	42.48	7.9	34.58	V
2728.6	42.4	7.8	34.6	V
2865.7	43.13	8.5	34.63	V
2955.7	43.29	8.7	34.59	V

GFSK Ch78 3GHz-18GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
13325.2	53.08	17	36.08	H
14295.0	55.55	20.8	34.75	H
15286.5	56.01	21.5	34.51	H
16101.6	58.39	24.8	33.59	H
16900.5	60	27.5	32.5	V
17723.4	59.42	27.5	31.92	V



GFSK Ch78 3GHz-18GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14295.0	42.81	20.8	22.01	H
15286.5	43.15	21.5	21.65	H
16101.6	46.89	24.8	22.09	H
16900.5	47.94	27.5	20.44	V
17723.4	47.35	27.5	19.85	V

 $\pi/4$ DQPSK Ch78 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
34.2	20.05	-22	42.05	V
34.6	16.44	-22	38.44	V
35.7	15.47	-21.8	37.27	V
41.5	22.08	-20.5	42.58	V
53.6	14.39	-20.7	35.09	V
100.5	16.48	-23.5	39.98	V

 $\pi/4$ DQPSK Ch78 1GHz-3GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2572.3	54.2	7.2	47	V
2645.2	54.43	7.7	46.73	H
2696.5	54.39	7.9	46.49	V
2761.6	54.24	7.7	46.54	V
2845.4	55.33	8.3	47.03	H
2891.1	56.05	8.8	47.25	V

 $\pi/4$ DQPSK Ch78 1GHz-3GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2572.3	41.65	7.2	34.45	V



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2645.2	42.4	7.7	34.7	H
2696.5	42.48	7.9	34.58	V
2761.6	42.44	7.7	34.74	V
2845.4	42.85	8.3	34.55	H
2891.1	43.53	8.8	34.73	V

π/4 DQPSK Ch78 3GHz-18GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14321.0	54.23	20.4	33.83	H
14759.7	55.59	20.8	34.79	V
15660.9	55.77	23.1	32.67	V
15995.3	59.36	25.4	33.96	V
16882.0	60.14	27.4	32.74	V
17793.9	61.19	28.4	32.79	V

π/4 DQPSK Ch78 3GHz-18GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14321.0	42.31	20.4	21.91	H
14759.7	42.71	20.8	21.91	V
15660.9	44.17	23.1	21.07	V
15995.3	47.18	25.4	21.78	V
16882.0	47.83	27.4	20.43	V
17793.9	47.68	28.4	19.28	V

8DPSK Ch78 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
34.4	12.36	-22	34.36	V
36.0	17.93	-21.7	39.63	V
93.1	26.02	-24.6	50.62	H



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172.8	19.68	-25.8	45.48	H
256.5	20.39	-22.7	43.09	V
842.5	22.29	-10.6	32.89	V

8DPSK Ch78 1GHz-3GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2524.2	53.9	6.8	47.1	V
2613.8	54.16	7.4	46.76	V
2656.7	54.91	7.7	47.21	V
2748.7	54.5	7.7	46.8	H
2843.9	55.5	8.3	47.2	V
2920.3	56.3	8.8	47.5	V

8DPSK Ch78 1GHz-3GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2613.8	41.99	7.4	34.59	V
2656.7	42.62	7.7	34.92	V
2748.7	42.52	7.7	34.82	H
2843.9	42.9	8.3	34.6	V
2920.3	43.49	8.8	34.69	V

8DPSK Ch78 3GHz-18GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14309.8	55.13	20.7	34.43	H
14687.5	55.49	21	34.49	V
15457.6	57.05	22.7	34.35	H
16295.0	59.05	25.7	33.35	V
16912.1	59.46	27.4	32.06	H
17516.0	60.15	27.6	32.55	H